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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/539,805	MASE ET AL.	
Examiner	Art Unit	
Danisa Tran	. 2405	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u>. </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (USPUB;USPAT;USOCR;EPOAB; JPOAB;DERWENT;IBM-TDB)	11/16/2005	DT
703/24;710/62;711/111;711/4;369/13. 37;369/30.01 (text search only, search history)	11/26/2006	DT
inventor name search	11/25/2006	DT
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